# UNISONIC TECHNOLOGIES CO., LTD

14NM95-Q **Preliminary Power MOSFET** 

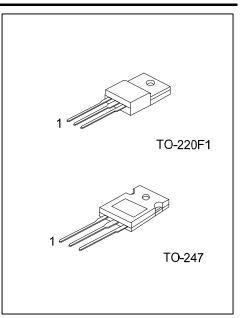
# **14A, 950V N-CHANNEL** SUPER-JUNCTION MOSFET

### **DESCRIPTION**

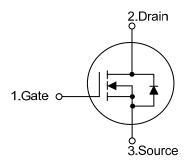
The UTC 14NM95-Q is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at AC-DC converters for power applications.

### **FEATURES**

- \*  $R_{DS(ON)} \le 0.58 \Omega$  @  $V_{GS}$ =10V,  $I_D$ =7.0A
- \* Fast switching capability
- \* Avalanche energy tested
- \* Improved dv/dt capability, high ruggedness



### **SYMBOL**



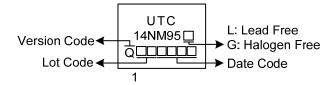
### **ORDERING INFORMATION**

Ordering Number		Daakana	Pin Assignment			Daakina	
Lead Free	Halogen Free	Package	1	2	3	Packing	
14NM95L-Q-TF1-T	14NM95G-Q-TF1-T	TO-220F1	G	D	S	Tube	
14NM95L-Q-T47-T	14NM95G-Q-T47-T	TO-247	G	D	S	Tube	

S: Source Note: Pin Assignment: G: Gate D: Drain 14NM95G-Q-TF1-T (1) T: Tube - (1)Packing Type (2) TF1: TO-220F1, T47: TO-247 (2)Package Type (3) Version Q (3)Version Code (4)Green Package (4) G: Halogen Free and Lead Free, L: Lead Free

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# ■ MARKING



# ■ ABSOLUTE MAXIMUM RATINGS (Tc=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{DSS}$	950	V	
Gate-Source Voltage		$V_{GSS}$	±30	V	
Drain Current	Cantinua	T <sub>C</sub> =25°C	· I <sub>D</sub>	14	Α
	Continuous	T <sub>C</sub> =100°C		9.1	Α
	Pulsed (Note	Pulsed (Note 2)		42	Α
Avalanche Energy	Single Pulsed	d (Note 3)	E <sub>AS</sub>	480	mJ
Peak Diode Recovery	dv/dt (Note 4)	dv/dt 1.27		V/ns	
Power Dissipation		P <sub>D</sub>	26	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 100mH,  $I_{AS}$  = 3.1A,  $V_{DD}$  = 90V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25 $^{\circ}$ C.
- 4.  $I_{SD} \le 14A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$ .

### **■ THERMAL DATA**

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θја	62.5	°C/W	
Junction to Case	θις	4.8	°C/W	

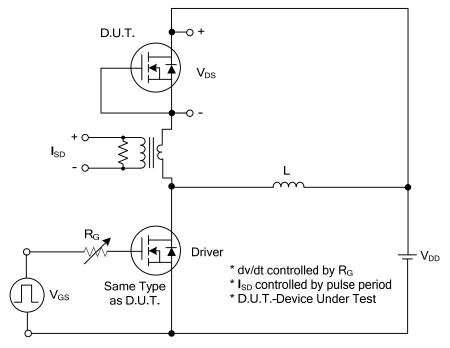
# ■ **ELECTRICAL CHARACTERISTICS** (TJ=25°C, unless otherwise specified)

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT			
OFF CHARACTERISTICS									
Drain-Source Breakdown Voltage	$BV_DSS$	$V_{GS}$ =0V, $I_D$ =250 $\mu$ A				V			
Drain-Source Leakage Current	$I_{DSS}$	V <sub>DS</sub> =950V, V <sub>GS</sub> =0V			10	μΑ			
Gate-Source Leakage Current	$I_{GSS}$	V <sub>GS</sub> =±30V, V <sub>DS</sub> =0V			±100	nA			
ON CHARACTERISTICS									
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$			4.5	V			
Static Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =7.0A			0.58	Ω			
DYNAMIC CHARACTERISTICS									
Input Capacitance	C <sub>ISS</sub>			1075		рF			
Output Capacitance	Coss	V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, f=1MHz		117		рF			
Reverse Transfer Capacitance	C <sub>RSS</sub>	7		3.3		рF			
SWITCHING CHARACTERISTICS									
Total Gate Charge	$Q_{G}$	700/// 40// 444		62		nC			
Gate-Source Charge	Q <sub>GS</sub>	V <sub>DS</sub> =760V, V <sub>GS</sub> =10V, I <sub>D</sub> =14A (Note 1, 2)		14		nC			
Gate-Drain Charge	$Q_{DD}$			27		nC			
Turn-On Delay Time	t <sub>D(ON)</sub>			9		ns			
Turn-On Rise Time	t <sub>R</sub>	V <sub>DD</sub> =100V, V <sub>GS</sub> =10V, I <sub>D</sub> =14A,		19		ns			
Turn-Off Delay Time	t <sub>D(OFF)</sub>	R <sub>G</sub> =25Ω (Note 1, 2)		52		ns			
Turn-Off Fall Time	t⊧			24		ns			
SOURCE- DRAIN DIODE RATINGS AND C	HARACTERI	STICS							
Maximum Continuous Drain-Source Diode					4.4				
Forward Current	Is				14	Α			
Maximum Pulsed Drain-Source Diode	1				42	Α			
Forward Current	I <sub>SM</sub>				42	А			
Drain-Source Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =14A, V <sub>GS</sub> =0V			1.4	V			
Body Diode Reverse Recovery Time	trr	I <sub>S</sub> =14A, V <sub>GS</sub> =0V,		560		nS			
Body Diode Reverse Recovery Charge	Qrr	dl <sub>F</sub> /dt=100A/µs		9.8		μC			
	_								

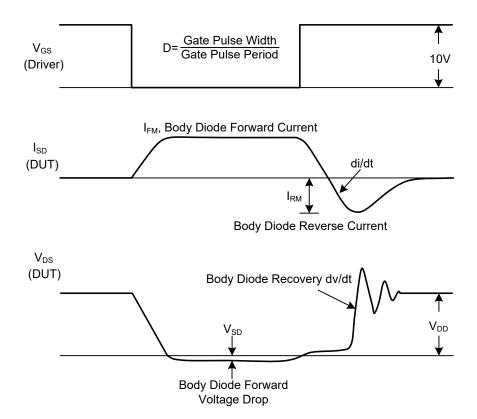
Notes: 1. Pulse Test: Pulse width  $\leq$  300 $\mu$ s, Duty cycle  $\leq$  2%.

<sup>2.</sup> Essentially independent of operating temperature.

## TEST CIRCUITS AND WAVEFORMS

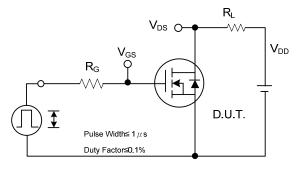


Peak Diode Recovery dv/dt Test Circuit

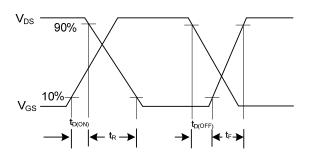


Peak Diode Recovery dv/dt Waveforms

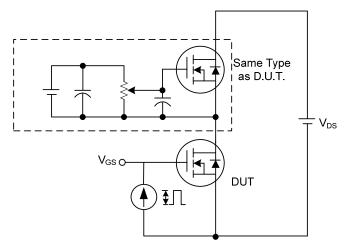
# **■ TEST CIRCUITS AND WAVEFORMS**



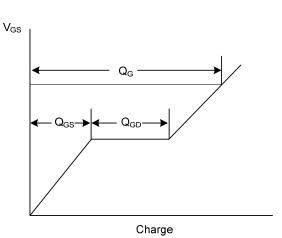
**Switching Test Circuit** 



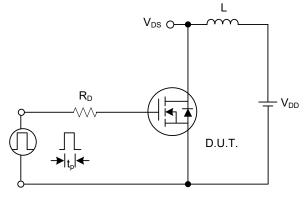
**Switching Waveforms** 



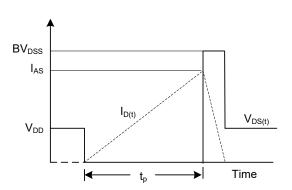
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



**Unclamped Inductive Switching Waveforms** 

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